

<b>Notice of References Cited</b>	Application/Control No. 09/776,669	Applicant(s)/Patent Under Reexamination LEE, YUAN-CHIEH	
	Examiner Stefano Karmis	Art Unit 3624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,704,714	03-2004	O'Leary et al.	705/39
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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